# **BUK9Y40-55B**

# N-channel TrenchMOS logic level FET Rev. 03 — 22 February 2008

Product data sheet

#### **Product profile** 1.

#### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using NXP High-Performance Automotive (HPA) TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features

- 175 °C rated
- Q101 compliant

- Logic level compatible
- Very low on-state resistance

### 1.3 Applications

- 12 V and 24 V loads
- General purpose power switching
- Automotive systems
- Motors, lamps and solenoids

#### 1.4 Quick reference data

Table 1. **Quick reference** 

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$I_D$	drain current	$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C};$ see Figure 1 and 4	-	-	26	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	-	59	W
Static ch	aracteristics					
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 ^{\circ}\text{C}; \text{ see } \underline{\text{Figure 12}} \text{ and } \underline{13}$	-	34	40	mΩ
Avalanci	Avalanche ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$\begin{split} I_D &= 26 \text{ A; } V_{sup} \leq 55 \text{ V;} \\ R_{GS} &= 50  \Omega; V_{GS} = 5 \text{ V;} \\ T_{j(init)} &= 25 ^{\circ}\text{C; } unclamped \end{split}$	-	-	36	mJ



# 2. Pinning information

Table 2. Pinning

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source	mb	D
2	S	source		
3	S	source		$_{G}$ $(\Box \overline{A})$
4	G	gate	<u> </u>	
mb	D	mounting base; connected to drain	1 2 3 4 SOT669 (LFPAK)	mbb076 S

# 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK9Y40-55B	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669

# 4. Limiting values

Table 4. Limiting values

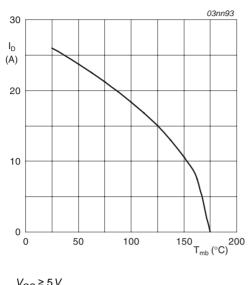
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	55	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$	-	55	V
$V_{GS}$	gate-source voltage		-15	15	V
I <sub>D</sub>	drain current	$T_{mb} = 100  ^{\circ}\text{C};  V_{GS} = 5  \text{V};  \text{see}  \frac{\text{Figure 1}}{}$	-	18	Α
		$T_{mb} = 25  ^{\circ}C; V_{GS} = 5  V; \text{ see } \underline{\text{Figure 1}} \text{ and } \underline{4}$	-	26	Α
$I_{DM}$	peak drain current	$T_{mb}$ = 25 °C; $t_p \le 10 \mu s$ ; pulsed; see <u>Figure 4</u>	-	106	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>	-	59	W
T <sub>stg</sub>	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Avalanci	he ruggedness				
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 26 A; $V_{sup} \le$ 55 V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped	-	36	mJ
E <sub>DS(AL)R</sub>	repetitive drain-source avalanche energy	see <u>Figure 3</u>	[1][2] - [3]	-	J
Source-o	drain diode				
I <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C	-	26	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$	-	106	Α

<sup>[1]</sup> Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.

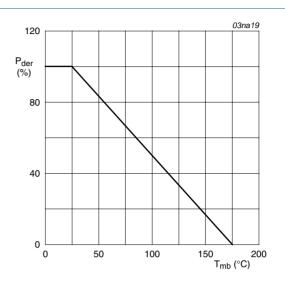
<sup>[2]</sup> Repetitive avalanche rating limited by average junction temperature of 170 °C.

<sup>[3]</sup> Refer to application note AN10273 for further information.



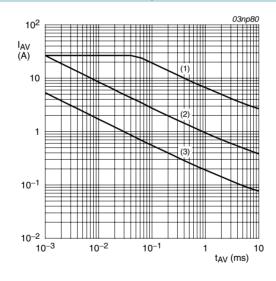
 $V_{GS} \ge 5 V$ 

Fig 1. Continuous drain current as a function of mounting base temperature



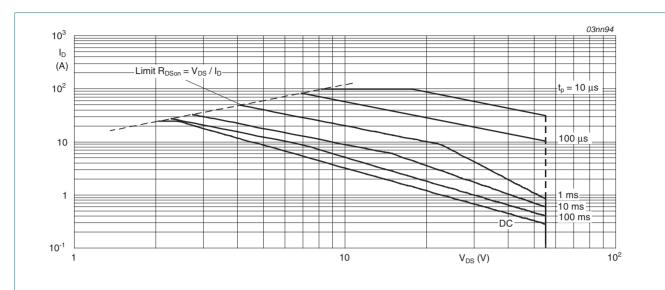
$$P_{der} = \frac{P_{tot}}{P_{tot(25\,\%)}} \times 100\,\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature



- (1) Single-pulse;  $T_i = 25 \, \text{C}$ .
- (2) Single-pulse;  $T_i = 150 \, \text{°C}$ .
- (3) Repetitive.

Single-shot and repetitive avalanche rating; avalanche current as a function of avalanche period



 $T_{mb}$  = 25 °C;  $I_{DM}$  is single pulse

Fig 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

# 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	-	2.5	K/W

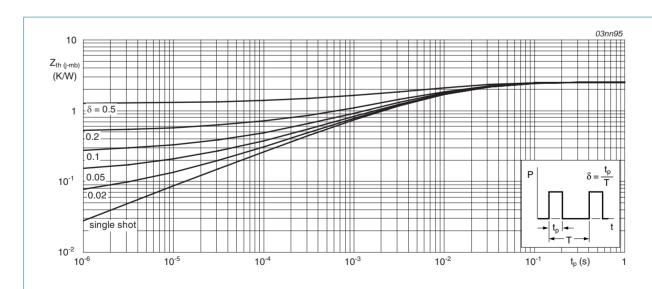
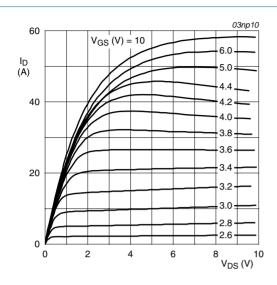


Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration

# 6. Characteristics

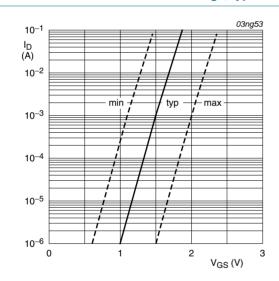
Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
	racteristics			- 3 F		2
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V};$ $T_j = 25 ^{\circ}\text{C}$	55	-	-	V
		$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V};$ $T_j = -55 \text{ °C}$	50	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 175 °C; see <u>Figure 11</u>	0.5	-	-	V
		$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = 25 °C; see <u>Figure 11</u>	1.1	1.5	2	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see <u>Figure 11</u>	-	-	2.3	V
$I_{DSS}$	drain leakage current	$V_{DS}$ = 55 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C	-	0.02	1	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V};$ $T_j = 175 \text{ °C}$	-	-	500	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 15 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	2	100	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -15 \text{ V};$ $T_j = 25 ^{\circ}\text{C}$	-	2	100	nA
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 15 \text{ A}; T_j = 175 ^{\circ}\text{C};$ see <u>Figure 12</u> and <u>13</u>	-	-	84	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 25 ^{\circ}\text{C}$	-	32	36	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 15 \text{ A}; T_j = 25 ^{\circ}\text{C}$	-	-	45	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 15 \text{ A}; T_j = 25 ^{\circ}\text{C};$ see Figure 12 and 13	-	34	40	mΩ
Source-di	rain diode					
$V_{SD}$	source-drain voltage	$I_S = 20 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$ see <u>Figure 16</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_S = 20 \text{ A}; \text{ d}I_S/\text{d}t = -100 \text{ A/}\mu\text{s};$	-	45	-	ns
Q <sub>r</sub>	recovered charge	$V_{GS}$ = -10 V; $V_{DS}$ = 30 V; $T_j$ = 25 °C	-	25	-	nC
Dynamic	characteristics					
$Q_{G(tot)}$	total gate charge	$I_D = 15 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	11	-	nC
$Q_{GS}$	gate-source charge	$T_j = 25 ^{\circ}\text{C}$ ; see Figure 14	-	2	-	nC
$Q_{GD}$	gate-drain charge		-	5	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V};$	-	765	1020	pF
C <sub>oss</sub>	output capacitance	f = 1 MHz; T <sub>j</sub> = 25 °C; - see Figure 15	-	123	148	pF
C <sub>rss</sub>	reverse transfer capacitance		-	71	97	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS} = 30 \text{ V}; R_L = 2.2 \Omega;$	-	17	-	ns
t <sub>r</sub>	rise time	$V_{GS} = 5 \text{ V}; R_{G(ext)} = 10 \Omega;$	-	93	-	ns
t <sub>d(off)</sub>	turn-off delay time	$-T_j = 25 ^{\circ}\text{C}$	-	35	-	ns
t <sub>f</sub>	fall time		-	72	-	ns



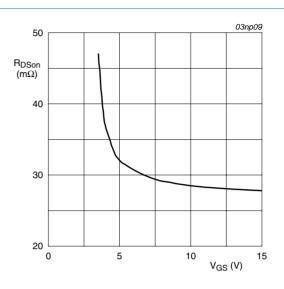
 $T_j = 25 \, \circ c; t_p = 300 \, \mu s$ 

Fig 6. Output characteristics: drain current as a function of drain-source voltage; typical values



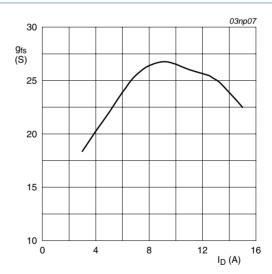
 $T_i = 25 \, \circ C; V_{DS} = V_{GS}$ 

Fig 8. Sub-threshold drain current as a function of gate-source voltage



$$T_i = 25 \, \text{°C}$$
;  $I_D = 15 \, A$ 

Fig 7. Drain-source on-state resistance as a function of gate-source voltage; typical values



$$T_i = 25 \text{ C}; V_{DS} = 25 \text{ V}$$

Fig 9. Forward transconductance as a function of drain current; typical values

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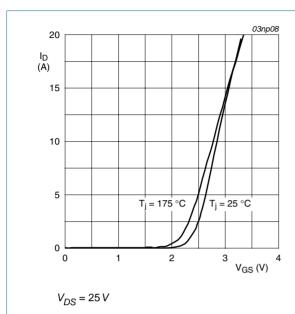


Fig 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

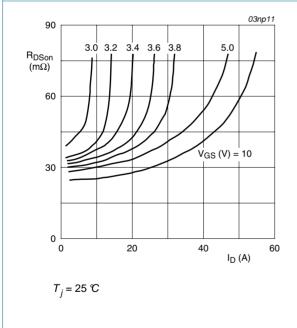
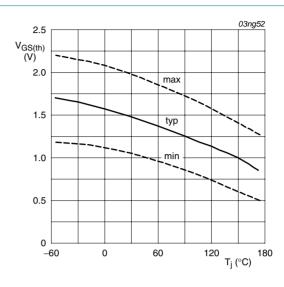


Fig 12. Drain-source on-state resistance as a function of drain current; typical values



$$I_D = 1 mA; V_{DS} = V_{GS}$$

Fig 11. Gate-source threshold voltage as a function of junction temperature

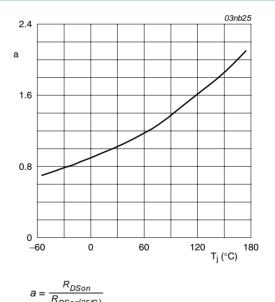
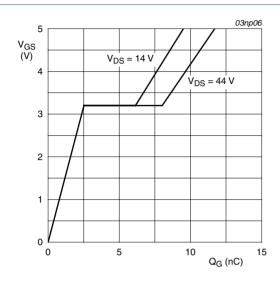


Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

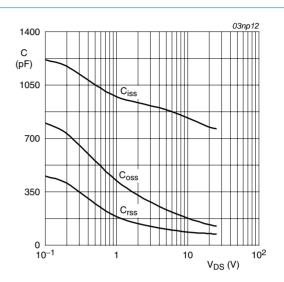
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 $T_i = 25 \text{ C}$ ;  $I_D = 15 \text{ A}$ 

charge; typical values

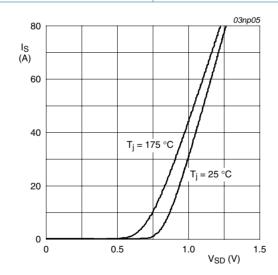
Fig 14. Gate-source voltage as a function of gate



 $V_{GS} = 0 V; f = 1 MHz$ 

Fig 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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 $V_{GS} = 0 V$ 

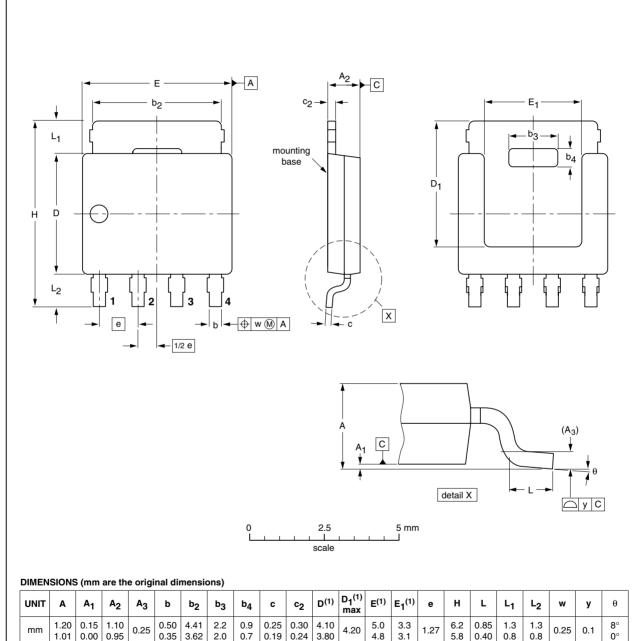
**Product data sheet** 

Fig 16. Source current as a function of source-drain voltage; typical values

# Package outline

#### Plastic single-ended surface-mounted package (LFPAK); 4 leads

**SOT669** 



1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT669		MO-235			<del>04-10-13</del> 06-03-16

Fig 17. Package outline SOT669 (LFPAK)

# 8. Revision history

#### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK9Y40-55B_3	20080222	Product data sheet	-	BUK9Y40-55B_2
Modifications:	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> </ul>			
	<ul> <li>Legal texts</li> </ul>	have been adapted to the	new company name whe	ere appropriate.
BUK9Y40-55B_2	20060411	Product data sheet	-	BUK9Y40_55B-01
BUK9Y40_55B-01	20040528	Product data sheet	-	-

## 9. Legal information

#### 9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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